

**Search Notes**

Application/Control No.

10/670,422

Examiner

Nam V. Nguyen

Applicant(s)/Patent under  
Reexamination

TAKI ET AL.

Art Unit

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	10.1	5/30/2006	NN
340	10.2	5/30/2006	NN
340	10.3	5/30/2006	NN
340	10.4-10.5	5/30/2006	NN
455	85	5/30/2006	NN
455	41-41.1	5/30/2006	NN
455	45-46	5/30/2006	NN
455	151.2	5/30/2006	NN
375	219	5/30/2006	NN
375	2,7	5/30/2006	NN
375	130-136	5/30/2006	NN
343	7.6	5/30/2006	NN
178	22	5/30/2006	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>SAME AS</b>	<b>ABOVE</b>	<b>5/30/2006</b>	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO; Derwent . (UPDATED SEARCH)	5/30/2006	NN
Consult with Tesfaldet Bocure (Art Unit 2631; Class 375)	11/14/2005	NN